

Notice of References Cited	Application/Control No. 10/607,138	Applicant(s)/Patent Under Reexamination HACK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0122123	09-2002	Kimura, Hajime	348/246
	B	US-2002/0140642	10-2002	Okamoto, Shigetsugu	345/76
	C	US-6,611,108	08-2003	Kimura, Hajime	315/169.3
	D	US-6,720,942	04-2004	Lee et al.	345/82
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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